

March 2013

# FCP380N60E / FCPF380N60E N-Channel SuperFET® II MOSFET

600 V, 10.2 A, 380 mΩ

#### **Features**

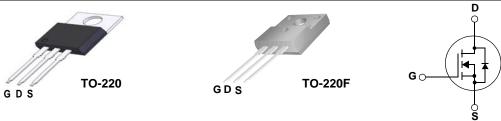
- 650 V @T<sub>.J</sub> = 150°C
- Max.  $R_{DS(on)} = 380 \text{ m}\Omega$
- Ultra Low Gate Charge ( Typ. Q<sub>g</sub> = 34 nC)
- Low Effective Output Capacitance (Typ. Coss.eff = 97 pF)
- 100% Avalanche Tested

## **Applications**

- LCD / LED / PDP TV Lighting
- · Solar Inverter
- AC-DC Power Supply

## **Description**

SuperFET<sup>®</sup>II MOSFET is Fairchild Semiconductor<sup>®</sup>'s first generation of high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, SuperFETII MOSFET is suitable for various AC/DC power conversion for system miniaturization and higher efficiency.



## **MOSFET Maximum Ratings** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol		Parameter		FCP380N60E	FCPF380N60E	Unit
V <sub>DSS</sub>	Drain to Source Voltage			6	00	V
V	Cata ta Sauraa Valtara	- DC		±	20	V
$V_{GSS}$	Gate to Source Voltage	- AC	(f > 1 Hz)	±	30	V
	Drain Current	-Continuous (T <sub>C</sub> = 25°C)		10.2	10.2*	^
ID	Drain Current	-Continuous (T <sub>C</sub> = 100°C)		6.4	6.4*	Α
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	30.6	30.6*	Α
E <sub>AS</sub>	Single Pulsed Avalanche Ene	rgy	(Note 2)	) 211.6		mJ
I <sub>AR</sub>	Avalanche Current		(Note 1)	ote 1) 2.3		Α
E <sub>AR</sub>	Repetitive Avalanche Energy		(Note 1)	1) 1.06		mJ
d. /dt	Peak Diode Recovery dv/dt		(Note 3)	3) 20		1//22
dv/dt	MOSFET dv/dt			1	00	V/ns
Б	Davier Dissipation	$(T_C = 25^{\circ}C)$		106	31	W
$P_{D}$	Power Dissipation	- Derate above 25°C		0.85 0.25		W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150		°С	
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			00	°C	

#### \*Drain current limited by maximum junction temperature

#### **Thermal Characteristics**

Symbol	Parameter	FCP380N60E	FCPF380N60E	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	1.18	4	
$R_{\theta CS}$	Thermal Resistance, Case to Heat Sink (Typical)	0.5	0.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FCP380N60E	FCP380N60E	TO-220	-	-	50
FCPF380N60E	FCPF380N60E	TO-220F	-	-	50

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Charac	cteristics					
D\/	Drain to Source Prockdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 25^{\circ}\text{C}$	600	-	-	V
BV <sub>DSS</sub> Drain to Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 10 \text{ mA}, T_J = 150^{\circ}\text{C}$	650	-	-	V	
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 10 mA, Referenced to 25°C	-	0.67	-	V/°C
BV <sub>DS</sub>	Drain-Source Avalanche Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 10 A	-	700	-	V
1	Zero Gate Voltage Drain Current	$V_{DS} = 480 \text{ V}, V_{GS} = 0 \text{ V}$	-	-	1	
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 480 \text{ V}, T_{C} = 125^{\circ}\text{C}$	-	-	10	μΑ
I <sub>GSS</sub>	Gate to Body Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	-	-	±100	nA

#### On Characteristics

V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	2.5	-	3.5	V
R <sub>DS(on)</sub>	Static Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$	-	0.32	0.38	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 20 \text{ V}, I_{D} = 5 \text{ A}$	-	10		S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V 05.V.V 0.V		1330	1770	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V}$ f = 1  MHz	-	945	1260	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1 101112	-	60	90	pF
C <sub>oss</sub>	Output Capacitance	$V_{DS} = 380 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$	-	25	-	pF
C <sub>oss</sub> eff.	Effective Output Capacitance	$V_{DS} = 0 \text{ V to } 480 \text{ V}, V_{GS} = 0 \text{ V}$	-	97	-	pF
Q <sub>g(tot)</sub>	Total Gate Charge at 10V		=	34	45	nC
Q <sub>gs</sub>	Gate to Source Gate Charge	$V_{DS} = 380 \text{ V}, I_{D} = 5 \text{ A}$	=	5.3	-	nC
Q <sub>gd</sub>	Gate to Drain "Miller" Charge	V <sub>GS</sub> = 10 V (Note 4)	-	13	-	nC
ESR	Equivalent Series Resistance	f = 1 MHz	-	6	-	Ω

#### **Switching Characteristics**

t <sub>d(on)</sub>	Turn-On Delay Time		-	17	44	ns
t <sub>r</sub>		$V_{DD} = 380 \text{ V}, I_{D} = 5 \text{ A}$	-	9	28	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$V_{GS} = 10 \text{ V}, R_G = 4.7 \Omega$	-	64	138	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)	-	10	30	ns

#### **Drain-Source Diode Characteristics**

$I_S$	Maximum Continuous Drain to Source Diode Forward Current			-	10.2	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	30.6	Α
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{SD} = 5 \text{ A}$	-	-	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>SD</sub> = 5 A	-	240	-	ns
Q <sub>rr</sub>	Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$	-	3	-	μС

#### Notes:

- ${\bf 1.}\ {\bf Repetitive}\ {\bf Rating:}\ {\bf Pulse}\ {\bf width}\ {\bf limited}\ {\bf by}\ {\bf maximum}\ {\bf junction}\ {\bf temperature}$
- 2.  $I_{AS}$  = 2.3 A,  $V_{DD}$  = 50 V,  $R_{G}$  = 25  $\Omega,$  Starting  $T_{J}$  = 25°C
- 3. I  $_{SD} \leq$  5.1 A, di/dt  $\leq$  200 A/ $\mu$ s, V  $_{DD} \leq$  BV  $_{DSS}$ , Starting T  $_{J}$  = 25°C
- 4. Essentially Independent of Operating Temperature Typical Characteristics

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

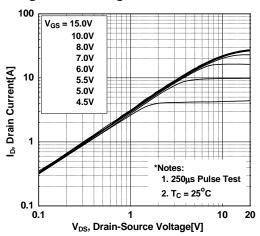


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

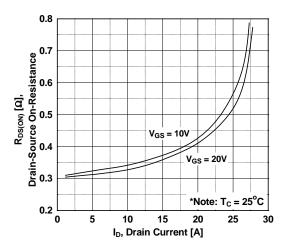
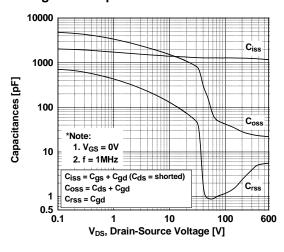


Figure 5. Capacitance Characteristics



**Figure 2. Transfer Characteristics** 

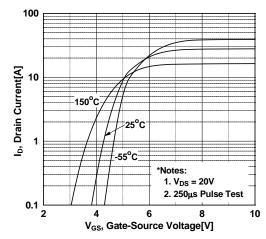


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

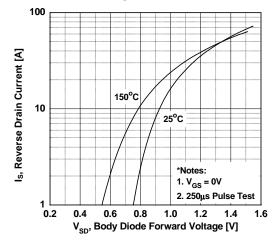
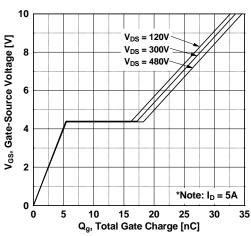


Figure 6. Gate Charge Characteristics



### **Typical Performance Characteristics** (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

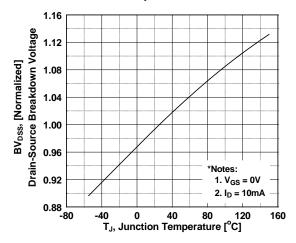


Figure 9. Maximum Safe Operating Area vs. Case Temperature - FCP380N60E

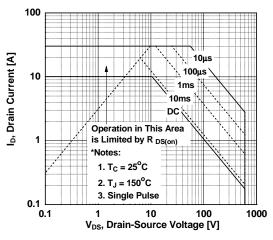


Figure 11. Maximum Drain Current

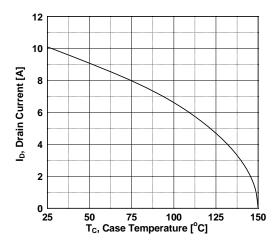


Figure 8. On-Resistance Variation vs. Temperature

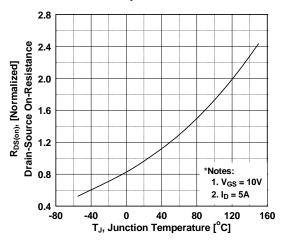


Figure 10. Maximum Safe Operating Area vs. Case Temperature - FCPF380N60E

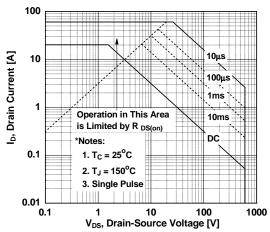
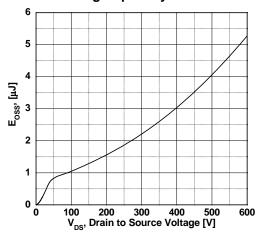


Figure 12. Eoss vs. Drain to Source Voltage Switching Capability



## **Typical Performance Characteristics** (Continued)

Figure 13. Transient Thermal Response Curve - FCP380N60E

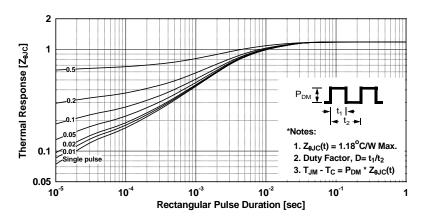
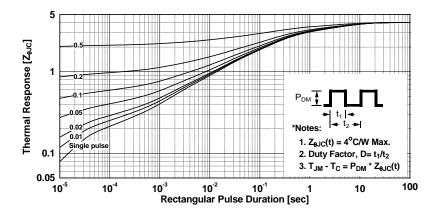
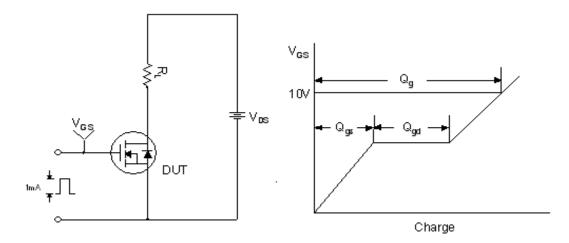


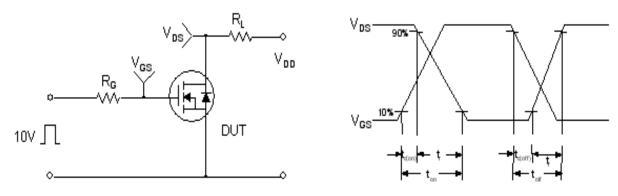
Figure 14. Transient Thermal Response Curve - FCPF380N60E



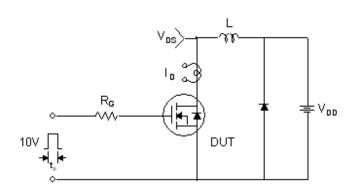
#### **Gate Charge Test Circuit & Waveform**

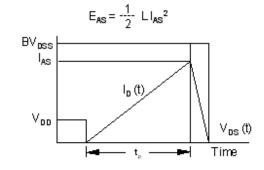


#### **Resistive Switching Test Circuit & Waveforms**

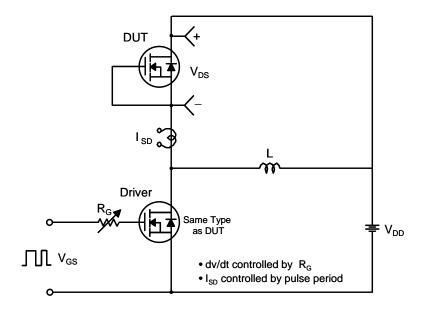


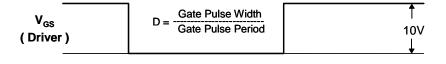
#### **Unclamped Inductive Switching Test Circuit & Waveforms**

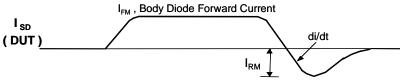




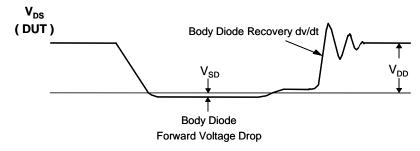
#### Peak Diode Recovery dv/dt Test Circuit & Waveforms





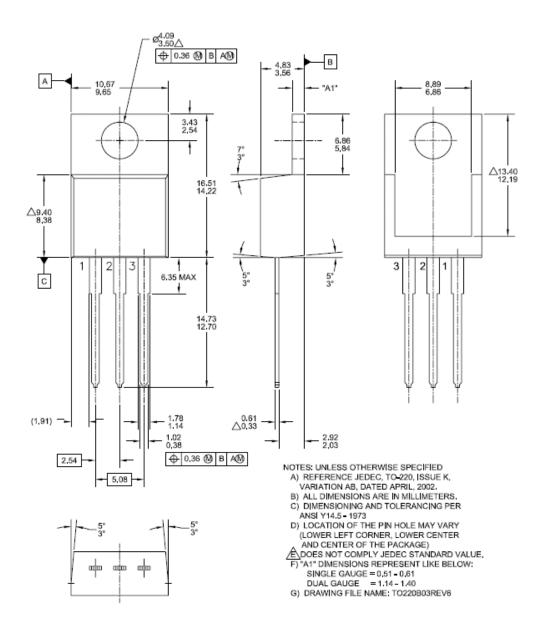


Body Diode Reverse Current



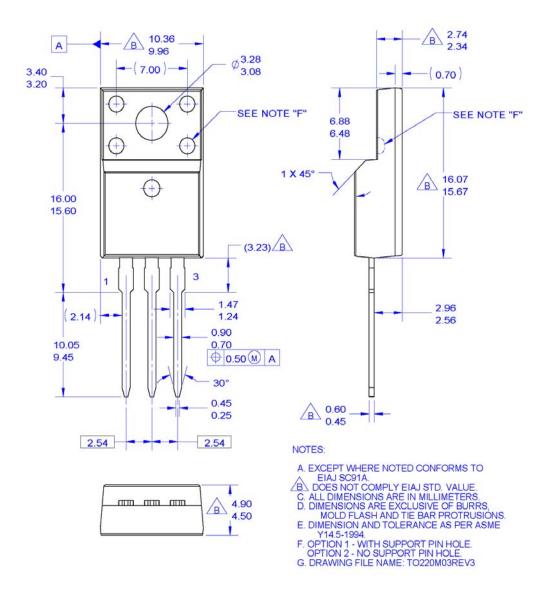
#### **Mechanical Dimensions**

# **TO-220AB**



## **Package Dimensions**

# TO-220F (Retractable)



\* Front/Back Side Isolation Voltage: AC 2500V

Dimensions in Millimeters





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